

EVVOSEMI[®]

THINK CHANGE DO



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

Product Specification

▶ Domestic	Part Number	IRF9317
▶ Overseas	Part Number	IRF9317
▶ Equivalent	Part Number	IRF9317

EV is the abbreviation of name EVVO

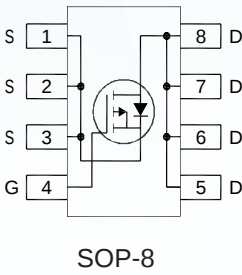
-30V P-Channel MOSFET

Applications

- Charge and Discharge Switch for Notebook PC Battery Application

Features

- $V_{DS} (V) = -30V$
- $I_D = -16A$ ($V_{GS} = -10V$)
- $R_{DS(ON)} < 6.6m\Omega$ ($V_{GS} = -10V$)
- $R_{DS(ON)} < 10.2 m\Omega$ ($V_{GS} = -4.5V$)



Features

Industry-Standard SO8 Package
RoHS Compliant Containing no Lead, no Bromide and no Halogen

Resulting Benefits

Multi-Vendor Compatibility
Environmentally Friendlier

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	-30	V
V_{GS}	Gate-to-Source Voltage	± 20	
I_D @ $T_A = 25^{\circ}C$	Continuous Drain Current, $V_{GS} @ 10V$	-16	A
I_D @ $T_A = 70^{\circ}C$	Continuous Drain Current, $V_{GS} @ 10V$	-13	
I_D	Pulsed Drain Current ①	-130	
P_D @ $T_A = 25^{\circ}C$	Power Dissipation ④	2.5	W
P_D @ $T_A = 70^{\circ}C$	Power Dissipation ④	1.6	
	Linear Derating Factor	0.02	W/°C
T_J	Operating Junction and Storage Temperature Range	-55 to + 150	°C

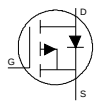
-30V P-Channel MOSFET
Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	-30			V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.022		V/ $^\circ\text{C}$	Reference to 25°C , $I_D = -1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance		5.4	6.6	$m\Omega$	$V_{GS} = -10V, I_D = -16A$ ③
			8.3	10.2		$V_{GS} = -4.5V, I_D = -13A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	-1.3	-1.8	-2.4	V	$V_{DS} = V_{GS}, I_D = -50\mu A$
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-5.7		mV/ $^\circ\text{C}$	
I_{DSS}	Drain-to-Source Leakage Current			-1.0	μA	$V_{DS} = -24V, V_{GS} = 0V$
				-150		$V_{DS} = -24V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage			-100	nA	$V_{GS} = -20V$
	Gate-to-Source Reverse Leakage			100		$V_{GS} = 20V$
g_{fs}	Forward Transconductance	36			S	$V_{DS} = -10V, I_D = -13A$
Q_g	Total Gate Charge ⑥		31		nC	$V_{DS} = -15V, V_{GS} = -4.5V, I_D = -13A$
Q_g	Total Gate Charge ⑥		61	92	nC	$V_{GS} = -10V$
Q_{gs}	Gate-to-Source Charge ⑥		9			$V_{DS} = -15V$
Q_{gd}	Gate-to-Drain Charge ⑥		14			$I_D = -13A$
R_G	Gate Resistance ⑥		14		Ω	
$t_{d(on)}$	Turn-On Delay Time		19		ns	$V_{DD} = -15V, V_{GS} = -4.5V$ ③
t_r	Rise Time		64			$I_D = -1.0A$
$t_{d(off)}$	Turn-Off Delay Time		160			$R_G = 6.8\Omega$
t_f	Fall Time		120			See Figs. 20a & 20b
C_{iss}	Input Capacitance		2820		pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance		640			$V_{DS} = -15V$
C_{rss}	Reverse Transfer Capacitance		370			$f = 1.0MHz$

Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②		330	mJ
I_{AR}	Avalanche Current ①		-13	A

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)			-2.5	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①			-130		
V_{SD}	Diode Forward Voltage			-1.2	V	$T_J = 25^\circ\text{C}, I_S = -2.5A, V_{GS} = 0V$ ③
t_{rr}	Reverse Recovery Time		33	50	ns	$T_J = 25^\circ\text{C}, I_F = -2.5A, V_{DD} = -24V$
Q_{rr}	Reverse Recovery Charge		30	45	nC	$di/dt = 100A/\mu s$ ③

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JL}$	Junction-to-Drain Lead ⑤		20	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient ④		50	

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 4.3mH$, $R_G = 25\Omega$, $I_{AS} = -13A$.
- ③ Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- ④ When mounted on 1 inch square copper board.
- ⑤ R_θ is measured at T_J of approximately 90°C .

-30V P-Channel MOSFET

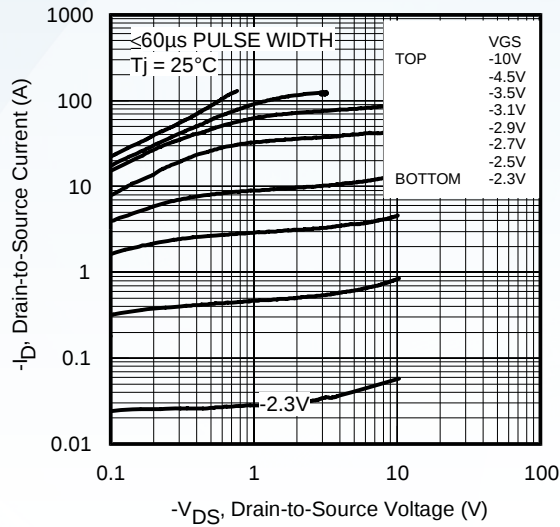


Fig 1. Typical Output Characteristics

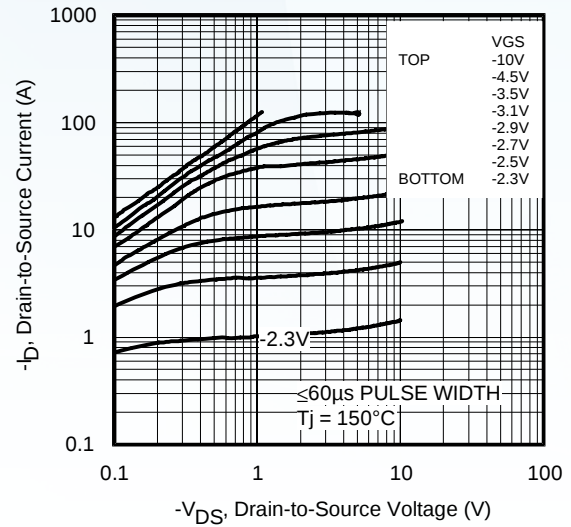


Fig 2. Typical Output Characteristics

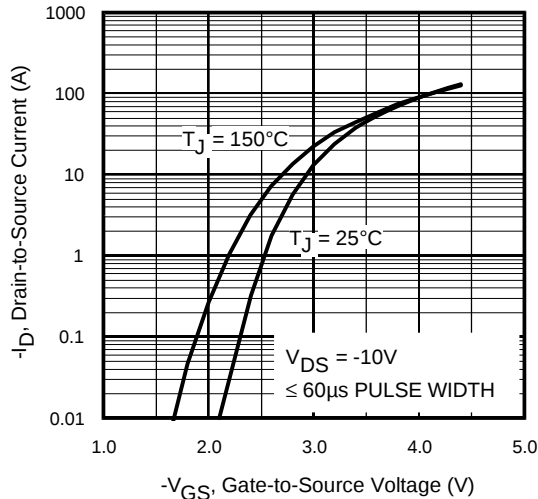


Fig 3. Typical Transfer Characteristics

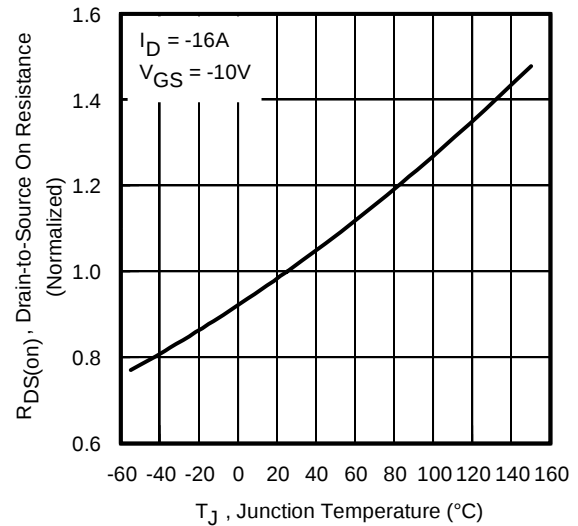


Fig 4. Normalized On-Resistance vs. Temperature

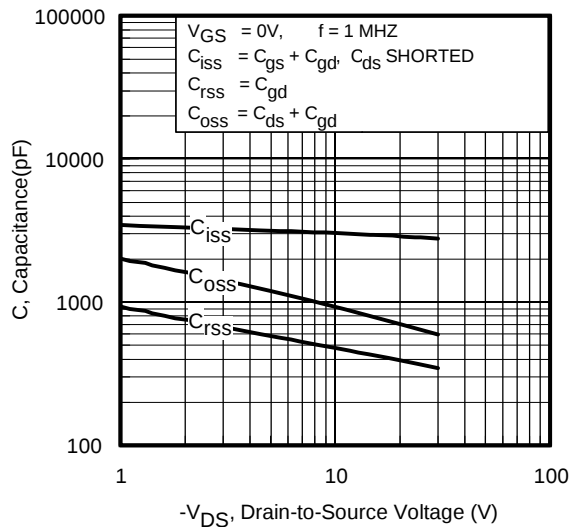


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

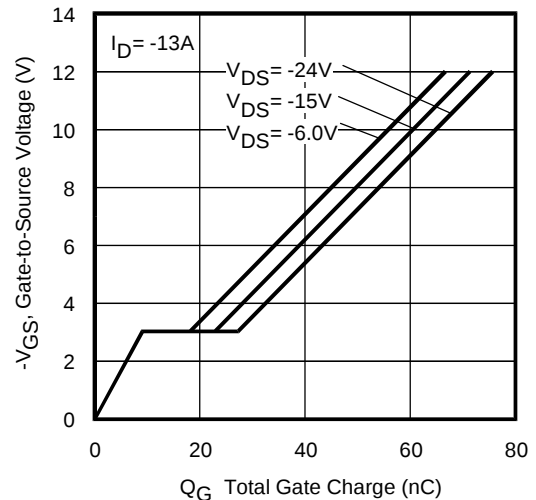


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

-30V P-Channel MOSFET

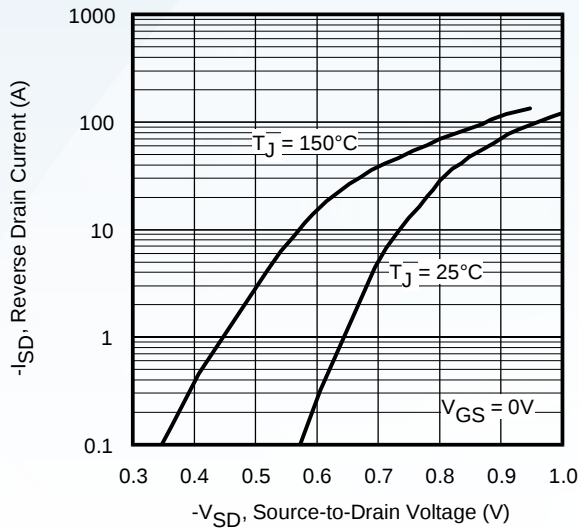


Fig 7. Typical Source-Drain Diode Forward Voltage

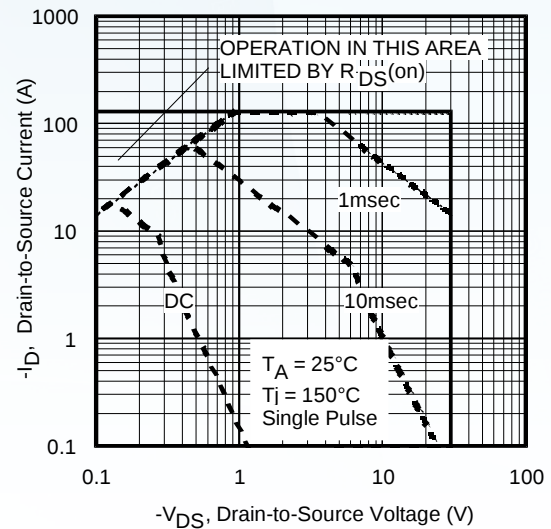


Fig 8. Maximum Safe Operating Area

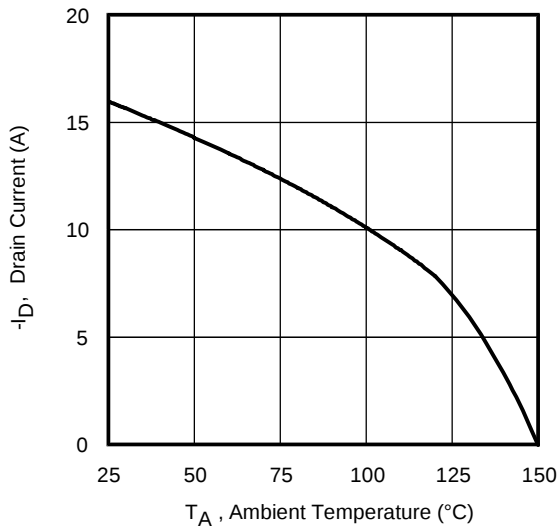


Fig 9. Maximum Drain Current vs. Ambient Temperature

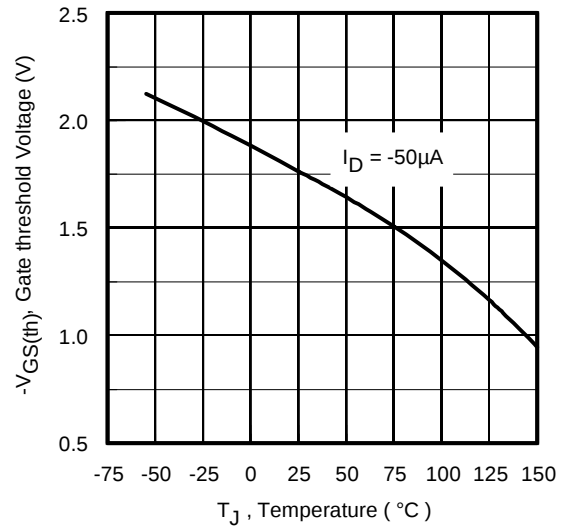


Fig 10. Threshold Voltage vs. Temperature

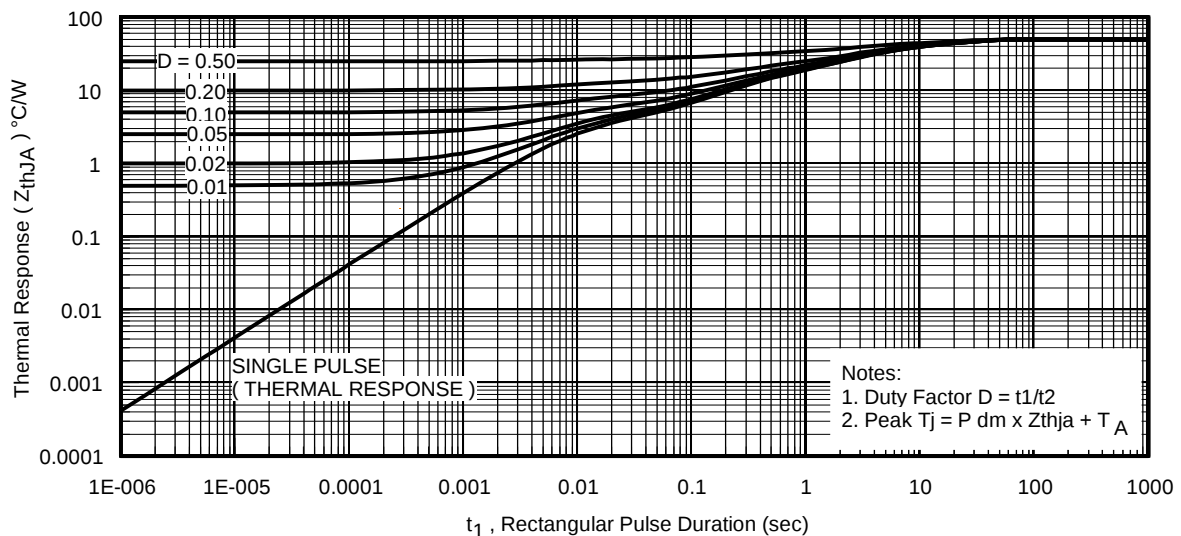


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

-30V P-Channel MOSFET

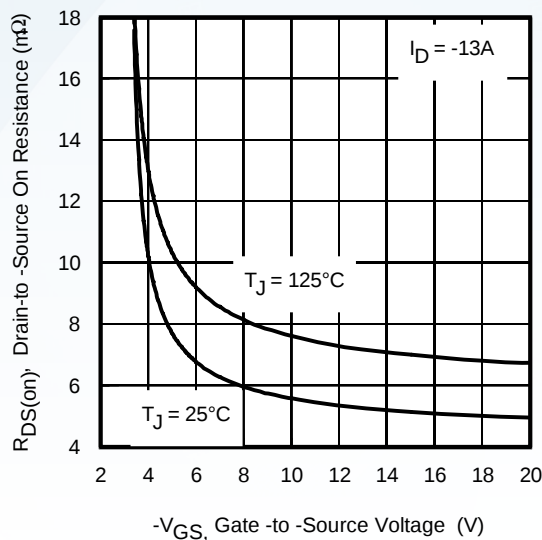


Fig 12. On-Resistance vs. Gate Voltage

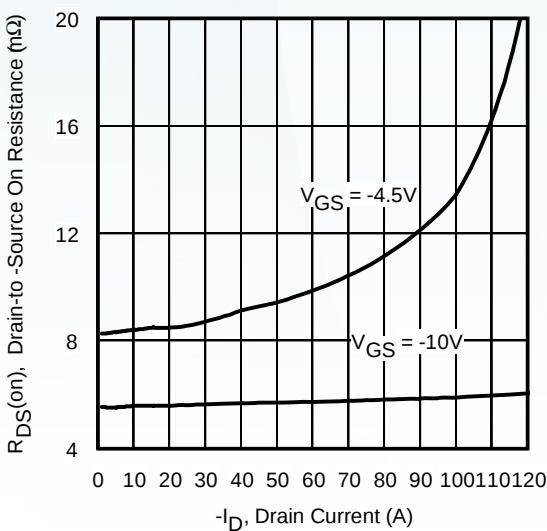


Fig 13. Typical On-Resistance vs. Drain Current

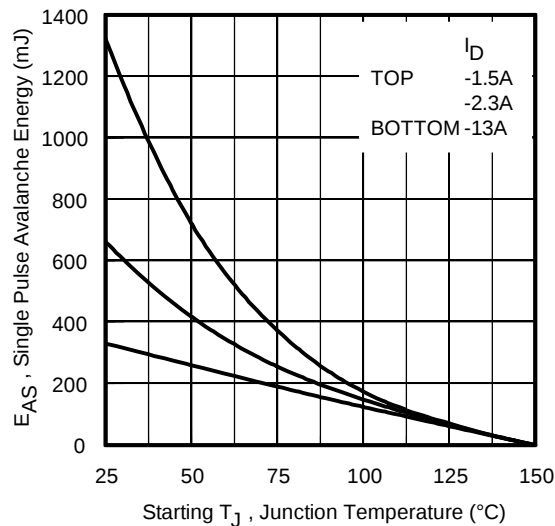


Fig 14. Maximum Avalanche Energy vs. Drain Current

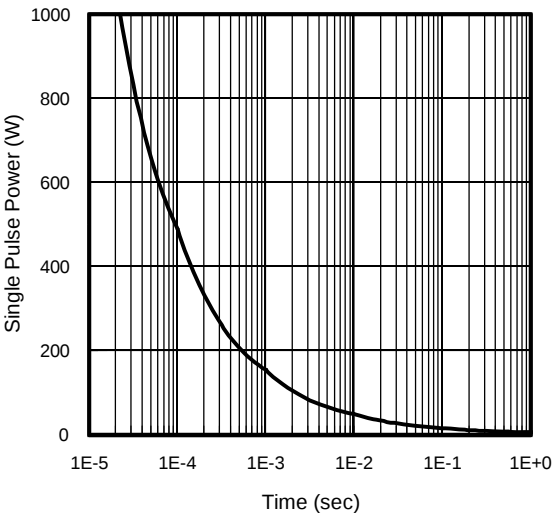


Fig 16. Typical Power vs. Time

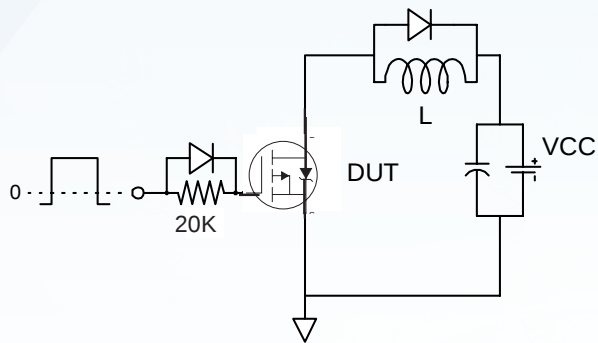


Fig 17a. Gate Charge Test Circuit

-30V P-Channel MOSFET

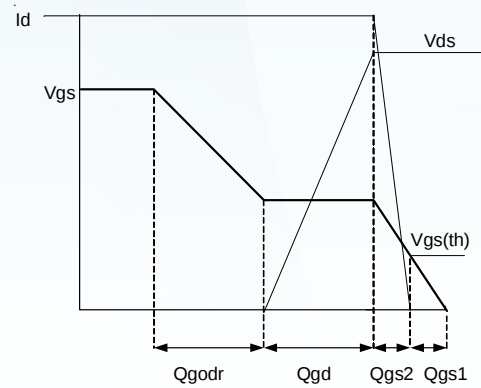


Fig 17b. Gate Charge Waveform

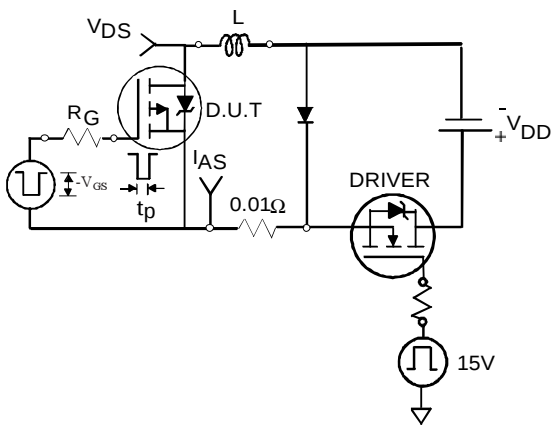


Fig 18a. Unclamped Inductive Test Circuit

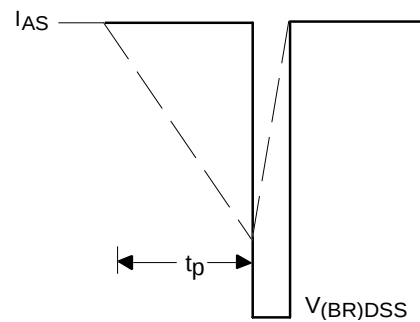


Fig 18b. Unclamped Inductive Waveforms

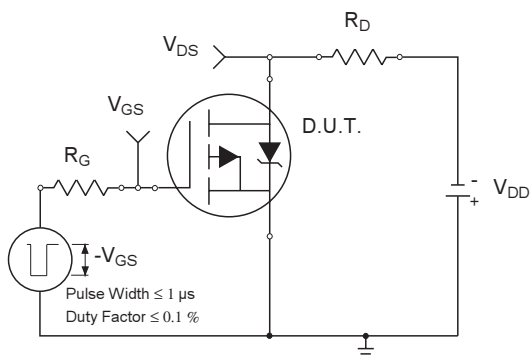


Fig 19a. Switching Time Test Circuit

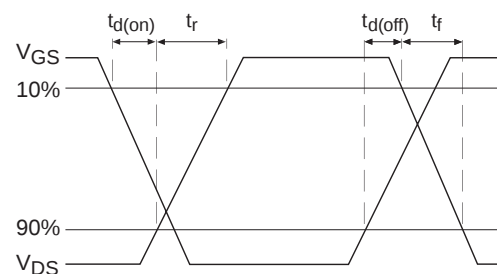
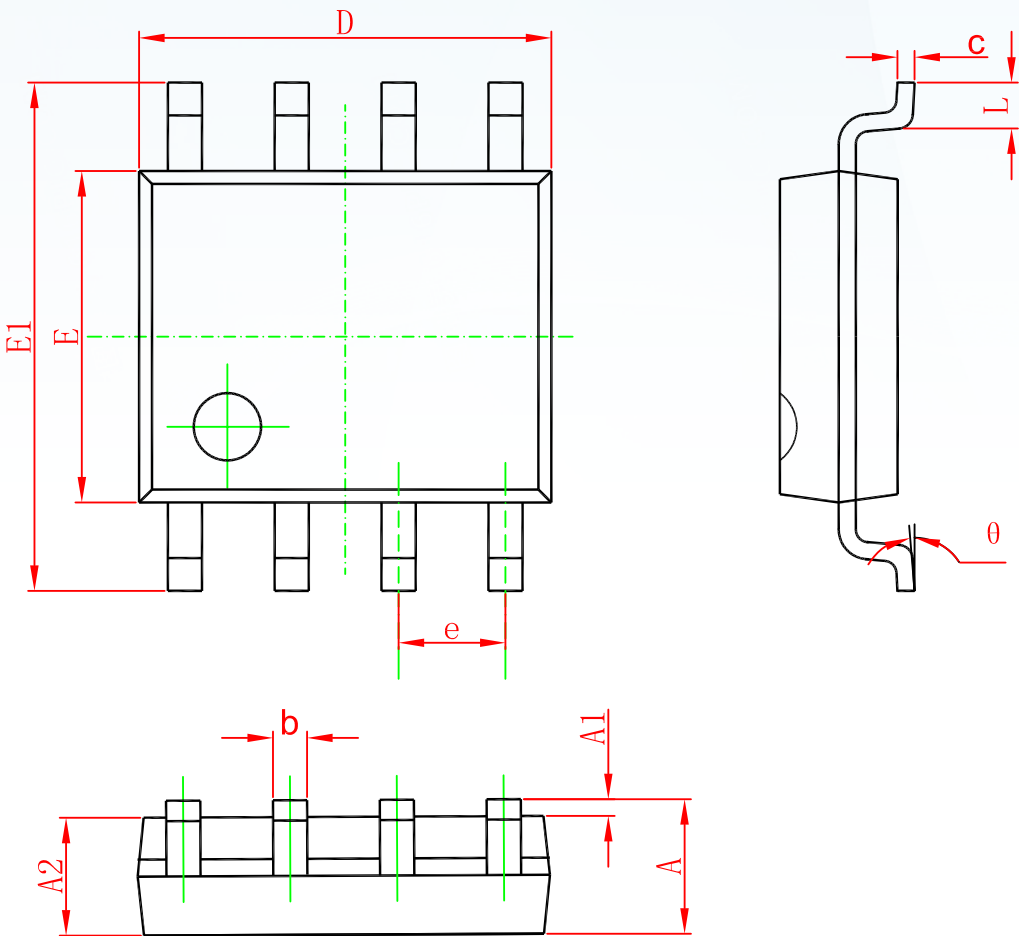


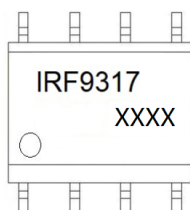
Fig 19b. Switching Time Waveforms

Package Mechanical Data SOP-8

-30V P-Channel MOSFET



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

-30V P-Channel MOSFET**Marking****Ordering information**

Order code	Package	Baseqty	Deliverymode
IRF9317	SOP-8	3000	Tape and reel

Disclaimer

EVVOSEMI ("EVVO") reserves the right to make corrections, enhancements, improvements, and other changes to its products and services at any time, and to discontinue any product or service without notice.

EVVO warrants the performance of its hardware products to the specifications applicable at the time of sale in accordance with its standard warranty. Testing and other quality control techniques are used as deemed necessary by EVVO to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

Customers should obtain and confirm the latest product information and specifications before final design, purchase, or use. EVVO makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does EVVO assume any liability for application assistance or customer product design. EVVO does not warrant or accept any liability for products that are purchased or used for any unintended or unauthorized application.

EVVO products are not authorized for use as critical components in life support devices or systems without the express written approval of EVVOSEMI.

The EVVO logo and EVVOSEMI are trademarks of EVVOSEMI or its subsidiaries in relevant jurisdictions. EVVO reserves the right to make changes without further notice to any products herein.